



P-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}$ (m Ω) (Typ.)	I _D (A) ^a	Q _g (Typ.)			
- 30	34 at V _{GS} = - 10 V	- 6.2	10 nC			
	43 at V _{GS} = - 4.5 V	- 5	10110			

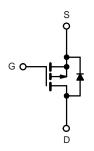
FEATURES

- DT-Trench Power MOSFET
- 100 % R_g and UIS Tested



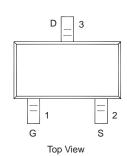
APPLICATIONS

- For Mobile Computing
 - Load Switch
 - Notebook Adaptor Switch
 - DC/DC Converter



P-Channel MOSFET

SOT-23-3L



ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)					
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	- 30	V	
Gate-Source Voltage		V_{GS}	± 20	V	
	T _C = 25 °C		- 6.2		
Continuous Drain Current (T _{.l} = 150 °C)	T _C = 70 °C	l _D	- 5.3		
Continuous Drain Current (1 _J = 150 °C)	T _A = 25 °C		- 3.5 ^{b,c}		
	T _A = 70 °C		- 2.2 ^{b,c}	A	
Pulsed Drain Current (t = 100 μs)		I _{DM}	- 25	1	
Continous Source-Drain Diode Current	T _C = 25 °C	I.	- 6		
	T _A = 25 °C	l _S	- 3.5 ^{b,c}		
Maximum Power Dissipation	T _C = 25 °C		2.6		
	T _C = 70 °C	P _D	1.7	\Box w	
	T _A = 25 °C		1.25 ^{b,c}		
	T _A = 70 °C		0.8 ^{b,c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b,d}	t ≤ 5 s	R _{thJA}	75	100	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	40	50		

Notes:

- a. Based on T_C = 25 °C. b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. Maximum under steady state conditions is 166 °C/W.

Rev. 1. 0 1

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static					•	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA	- 30			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L = 250 uA		- 19		mV/°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		4		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_{D} = -250 \mu A$	- 1		- 2.5	V
Gate-Source Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = ± 20 V			± 100	nA
7 0 1 1/1 1 2 1 2	I _{DSS}	V _{DS} = - 30 V, V _{GS} = 0 V			- 1	μΑ
Zero Gate Voltage Drain Current		V _{DS} = - 30 V, V _{GS} = 0 V, T _J = 55 °C			- 5	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -10 \text{ V}$	- 6			Α
		V _{GS} =- 10 V, I _D = - 5 A		34	42	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} =- 4.5 V, I _D = - 3 A		43	53	mΩ
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 5 V, I _D = - 5 A		18		S
Dynamic ^b						•
Input Capacitance	C _{iss}			695		pF
Output Capacitance	C _{oss}	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		90		
Reverse Transfer Capacitance	C _{rss}			55		
Total Gate Charge	Q_g			16	28	nC
Gate-Source Charge	Q _{gs}	V _{DS} = - 15 V, V _{GS} = - 10 V, I _D = - 5 A		2.5		
Gate-Drain Charge	Q _{gd}			5.8		
Gate Resistance	R _g	f = 1 MHz		8		Ω
Turn-On Delay Time	t _{d(on)}			18		
Rise Time	t _r	V_{DD} = - 15 V, R_L = 3.5 Ω $I_D \cong$ - 5 A, V_{GEN} = - 10 V, R_g = 1 Ω		9		ns
Turn-Off Delay Time	t _{d(off)}			30		
Fall Time	t _f			8		
Turn-On Delay Time	t _{d(on)}			36		
Rise Time	t _r	$V_{DD} = -15 \text{ V}, R_{L} = 3.5 \Omega$		15		
Turn-Off Delay Time	t _{d(off)}	$I_{D} \cong -3 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_{g} = 1\Omega$		45		
Fall Time	t _f			60		
Drain-Source Body Diode Characteristic	s					
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 6.2	A
Pulse Diode Forward Current ($t = 100 \mu s$)	I _{SM}				- 25	
Body Diode Voltage	V_{SD}	I _S = - 5 A, V _{GS} = 0 V		- 0.8	- 1.2	V
Body Diode Reverse Recovery Time	t _{rr}	t _{rr}		18	25	ns
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = - 5 A, dl/dt = 100 A/μs, T _J = 25 °C		10	18	nC
Reverse Recovery Fall Time	ta	- 1F=-3A, αι/αι=100 Αγμ5, 1J=25 C		12		ns
Reverse Recovery Rise Time	t _b	1		15		

Notes:

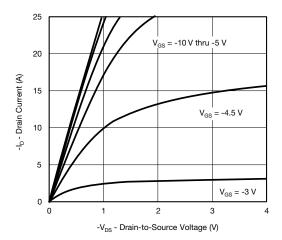
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$

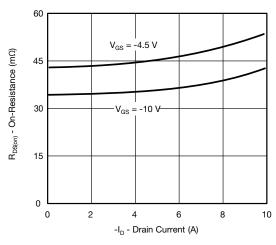
b. Guaranteed by design, not subject to production testing.



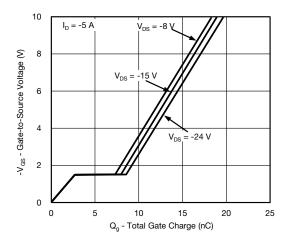
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



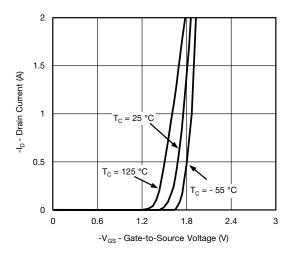
Output Characteristics



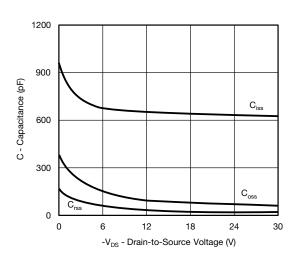
On-Resistance vs. Drain Current



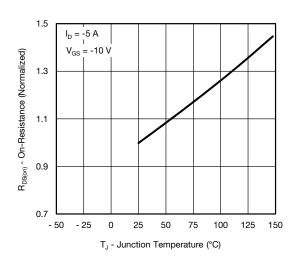
Gate Charge



Transfer Characteristics



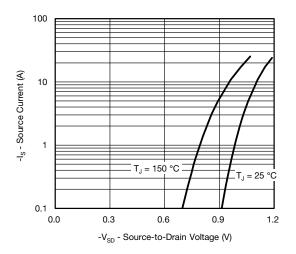
Capacitance



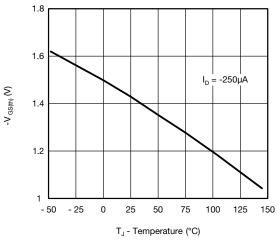
On-Resistance vs. Junction Temperature



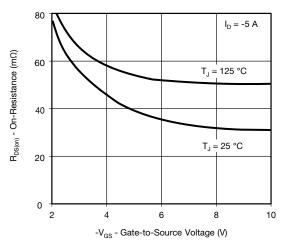
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



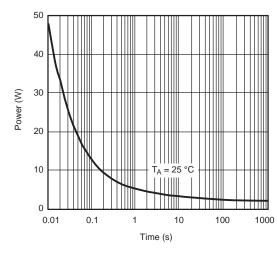
Source-Drain Diode Forward Voltage



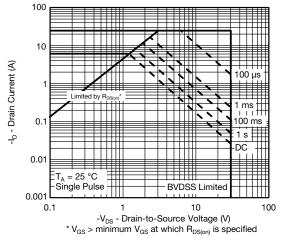
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage



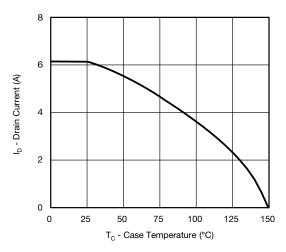
Single Pulse Power (Junction-to-Ambient)



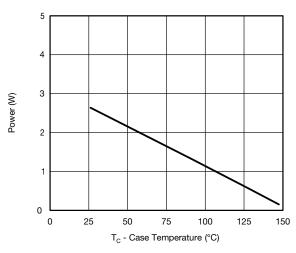
Safe Operating Area, Junction-to-Ambient

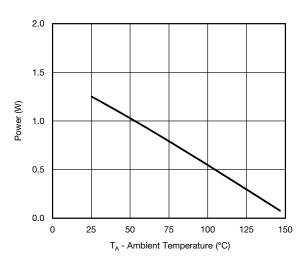
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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating*



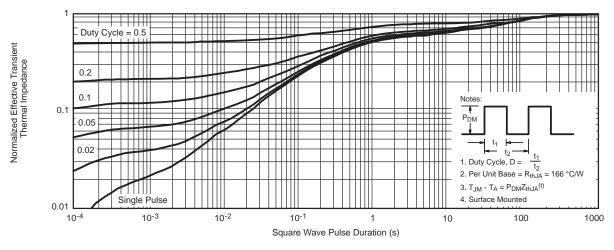


Power, Junction-to-Foot Power, Junction-to-Ambient

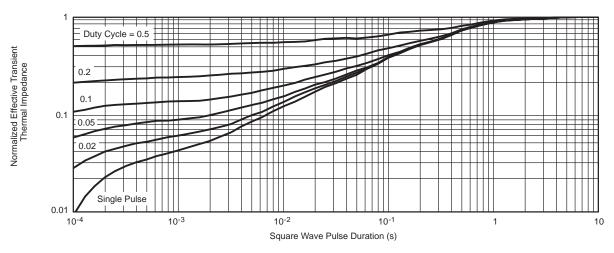
^{*} The power dissipation P_D is based on $T_{J(max.)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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